

Enhancement Mode P-Channel Power MOSFET

SOT23/PMOS/-20V/ \pm 12V/-0.75V/-2.3A/98m Ω

Rev1.3





-20V, $98m\Omega$, -2.3A, P-Channel MOSFET

1.Features

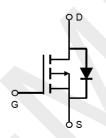
- Advanced Trench Technology
- ◆ Surface mount package

2.Applications

- Power Management
- Load Switching







Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.	
WP2301	A1sHB	SOT23	3,000	120,000	

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	-20	V
Gate to Source Voltage	V _{GSS}	±12	V
Drain Current (DC)	I _D	-2.3	А
Drain Current (Pulse), PW≤300μs	I _{DP}	-8	А
Total Dissipation	P _D	0.8	W
Junction Temperature	Tj	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{ heta JA}$	156	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10 sec$ The value in any given application depends on the user's specific board design.

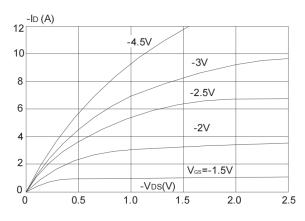
6.Electrical Characteristics at Ta=25°C (Note 3)

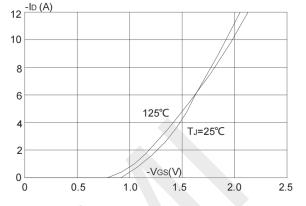
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	I _D = -250µA, V _{GS} = 0V	-20	-22		V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = -20V, V _{GS} = 0V			-1	μΑ
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =-250μA	-0.5	-0.75	-1.2	V
Static Drain to Source On-State	_	I _D =-2.3A, V _{GS} =-4.5V		98	120	mΩ
Resistance	R _{DS(on)}	I _D =-1A, V _{GS} = -2.5V		125	180	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		185		pF
Output Capacitance	Coss	V _{DS} =-10V,		35		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		25		pF
Turn-ON Delay Time	t _{d(on)}			10		ns
Rise Time	tr	V _{DD} =-10V, R _L =-5A,		30		ns
Turn-OFF Delay Time	$t_{d(off)}$	$R_G = 3.3\Omega, V_{GS} = -4.5V$		63		ns
Fall Time	t _f			50		ns
	Qg	V _{DS} = -10V,		2.2		nC
Total Gate Charge	Qgs	$V_{GS} = -4.5V$,		0.5		nC
	Q _{gd}	$I_D = -2.3A$		0.5		nC
Diode Forward Voltage	V_{FSD}	I _S = -2.3A, V _{GS} = 0		-0.55	-1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



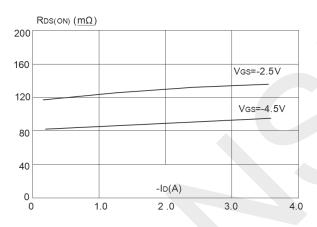
7. Typical Electrical and Thermal Characteristics

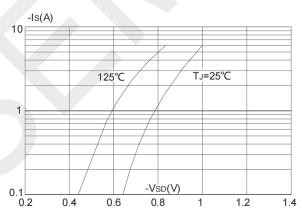




Output Characteristics

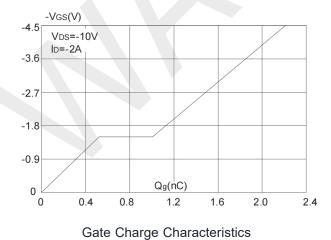
Typical Transfer Characteristics

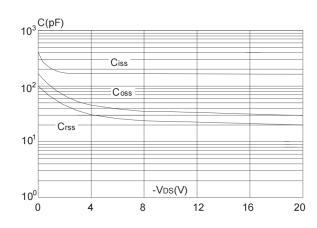




On-resistance vs . Drain Current

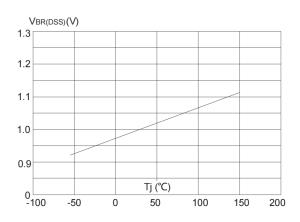
Body Diode Characteristics





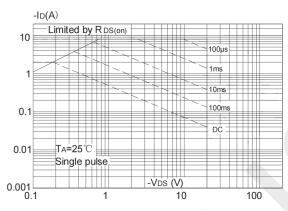
Capacitance Characteristics



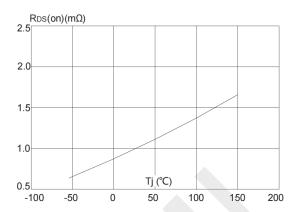


Normalized Breakdown Voltage vs.

Junction Temperature

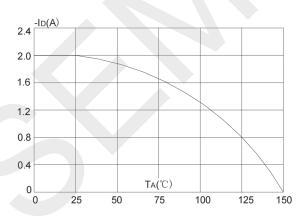


Maximum Safe Operating Area



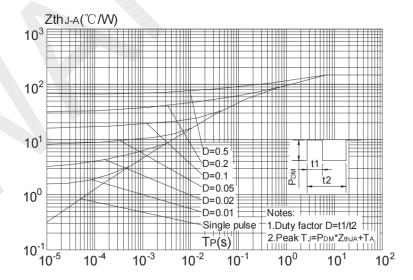
Normalized on Resistance vs.

Junction Temperature



Maximum Continuous Drain Current vs.

Case Temperature

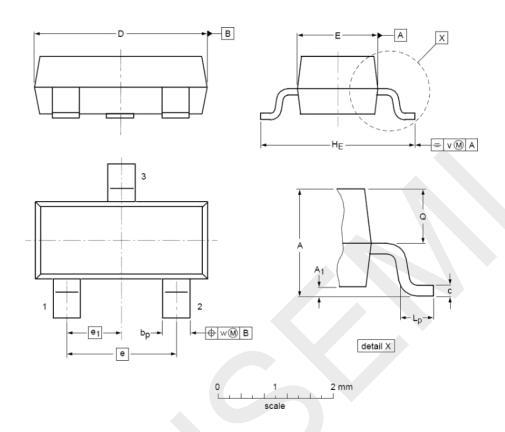


Maximum Effective Transient

Thermal Impedance, Junction-to-Case



8.Package Dimensions



DIMENSIONS (unit : mm)

Symbol	Min	Тур	Max	Symbol	Min	Тур	Max
Α	0.90	1.01	1.15	A ₁	0.01	0.05	0.10
bp	0.30	0.42	0.50	С	0.08	0.13	0.15
D	2.80	2.92	3.00	E	1.20	1.33	1.40
е	-	1.90		e ₁		0.95	
HE	2.25	2.40	2.55	L _p	0.30	0.42	0.50
Q	0.45	0.49	0.55	٧		0.20	
w		0.10	**				



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